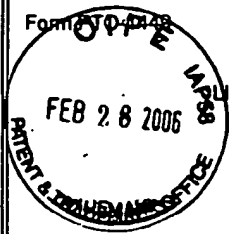


Form PTO-0148 		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1913		SERIAL NO. 10/050,334	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Vishnu K. Agarwal			
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U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
<i>TN</i> <div style="border-left: 1px solid black; height: 100px; margin: 0 auto; width: 20px;"></div>	AA	2002/0153579	10/2002	Yamamoto			
	AB	2002/0182820 A1	12/2002	Choi et al.			
	AC	2002/0197744 A1	12/2002	Lee			
	AD	2004/0018747 A1	01/2004	Lee et al.			
	AE	2004/0125541 A1	07/2004	Chung			
	AF	6,849,505 B2	02/2005	Lee et al.			
	AG	6,946,342 B2	09/2005	Yeo et al.			
	AH						
	AI						

FOREIGN PATENT DOCUMENTS								
Examiner's Initials	Document Number	Date	Country	Class	Subclass	Translation		
						Yes	No	
<i>TN</i>	AJ	JP 2002/222934 A	08/2002	Japan			ABST.	
	AK							
	AL							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
	AM		
	AN		
	AO		

EXAMINER <i>T. N. NGUYEN</i>	DATE CONSIDERED <i>4/19/06</i>
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. M122-1913		SERIAL NO. 10/050,334	
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U.S. PATENT DOCUMENTS								
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
	AA	2005/0082593 A1	04/2005	Lee et al.				
	AB	2003/0215960	11/2003	Mitsuhashi				
	AC	6,824,816	11/2004	Aaltonen et al.				
	AD	6,307,730	10/2001	Yamanishi				
	AE	6,800,892	10/2004	Bhattacharyya				
	AF							
	AG							
	AH							
	AI							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AM							
	AN							
	AO							
EXAMINER		DATE CONSIDERED						
T. NGUYEN		4/19/06						
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								